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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

App.	William D. Armstrong et al
Serial No.	10/557,999
Filed	November 18, 2005
For	OSCILLATORY MOTION BASED MEASUREMENT METHOD AND SENSOR FOR MEASURING WALL SHEAR STRESS DUE TO FLUID FLOW
Docket No.	W002.PAT-29

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, Virginia 22313-1450

I HEREBY CERTIFY THAT THIS PAPER
IS BEING SENT BY U.S. MAIL, FIRST
CLASS, TO THE COMMISSIONER FOR
PATENTS, P.O. BOX 1450,
ALEXANDRIA, VIRGINIA 22313-1450,
THIS

23d DAY OF March, 2006.

E2n
PATENT ATTORNEY

Sir:

The references listed on the enclosed PTO Form-1449 are submitted pursuant to 37 C.F.R. § 1.97.

Copies of the references are enclosed.

This information disclosure statement is being filed with the application or within three months of the filing date of the application or date of entry into the national stage of an international application or, to the best of the undersigned's knowledge, before the mailing date of a first Office Action on the merits, whichever event occurs last. In accordance with 37 C.F.R. § 1.97(b), no certification or fee is required.

Respectfully submitted,

WILLIAM D. ARMSTRONG et al

By:

3252
Emery L. Tracy, Reg. No. 34,081
P.O. Box 1518
Boulder, Colorado 80306
Phone: (303) 443-1143 Fax: (303) 443-1415

FORM PTO-1449		Atty. Docket No.: W002.PAT-29	Serial No.: 10/557,999
<p style="text-align: center;">LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT</p> <div style="text-align: center; border: 1px solid black; border-radius: 50%; padding: 5px; margin-top: 10px;"> O I P E U.S. PATENT & TRADEMARK OFFICE MAR 27 2006 </div>		Applicant:	
		William D. Armstrong et al	
		Filing Date	Group Art:
		November 18, 2005	

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
AA	5,199,298	04/06/1993	Ng et al			
AB	6,341,532	01/29/2002	Xu et al			
AC	6,426,796	07/30/2002	Pulliam et al			
AD						
AE						
AF						
AG						
AH						
AI						
AJ						
AK						
AL						

FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Sub Class	Translation Yes No
	AM						
	AN						
	AO						

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

AP	
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EXAMINER:

DATE CONSIDERED:

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.